Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	18862	imag\$3 and (slot\$1 or slit\$ or line\$1) and (detect\$ near3 (motion\$ or movement\$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/07/30 14:13
S2	4510	imag\$3 and ((slot\$1 or slit\$ or line\$1) same (detect\$ near3 (motion\$ or movement\$1)))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/07/30 14:13
S3	331	imag\$3 and (slit\$ same (detect\$ near3 (motion\$ or movement\$1)))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/07/30 14:19
S4	405	shukla.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/07/30 15:04
S5	3	"11134506".pn.",08221577".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:15
S6	783771	hitachi.as.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:16
S7	76768	hitachi.as. and mov\$5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:16
S8	1653	(hitachi.as. and mov\$5) and slit	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:18
S9	20176	Hirokazu.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:19
S10	1086	hitachi.as. and Hirokazu.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:19

S11	38389	yasuyuki.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:19
S12	11	(hitachi.as. and Hirokazu.in.) and yasuyuki.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:19
S13		"6584211".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:44
S14	1317	382/103,104,107.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:45
S15	502	382/103,104,107.ccls. and (segment\$6 or slit\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:45
S16	26	382/103,104,107.ccls. and slit\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:46
S17	5	(double near6 slit\$1) same (detect\$6 near5 (mov\$6 or motion\$))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 14:05
S18	1874	double near6 slit\$1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 14:06
S19	58	(double near6 slit\$1) and (object near4 (motion or mov\$6))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 14:07
S20	40	((double near6 slit\$1) and (object near4 (motion or mov\$6))) and image\$1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR "	OFF	2004/09/03 14:07

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S21	40	((double near6 slit\$1) and (object near4 (motion or mov\$6))) and image\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 14:07
S22	40	((double near6 slit\$1) and (object near4 (motion or mov\$6))) and imag\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 14:07
S23	7	(US-6005493-\$ or US-6766038-\$ or US-5771485-\$ or US-5329595-\$). did. or (JP-08221577-\$).did. or (EP-913799-\$ or JP-08221577-\$). did.	USPAT; JPO; DERWENT	OR	OFF	2004/09/06 14:42
S24	1	((US-6005493-\$ or US-6766038-\$ or US-5771485-\$ or US-5329595-\$). did. or (JP-08221577-\$).did. or (EP-913799-\$ or JP-08221577-\$).	US-PGPUB; USPAT; EPO; JPO;	OR	OFF	2004/09/06 14:45
6		did.) and (object near4 (length or height))	DERWENT; IBM_TDB			
S25	0	((US-6005493-\$ or US-6766038-\$ or US-5771485-\$ or US-5329595-\$). did. or (JP-08221577-\$).did. or (EP-913799-\$ or JP-08221577-\$). did.) and (object near4 (height))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:45
\$26	684	slit\$1 and (object near4 (height))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:45
S27	30	slit\$s and (determin\$6 near4 (object near4 height))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:47
S28	30	slit\$s and (determin\$6 near4 ((mov\$5near3 object) near4 height))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:47
S29	1	slit\$s and (determin\$6 near4 ((mov\$5 near3 object) near4 height))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:52
S30	2	"6584211".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:52

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S31	1	"6584211".pn. and (length or height)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:31
S32	1	"5721692".pn. and (length or height)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:54
S33	784227	Hitachi.as.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:31
S34	196	Hitachi.as. and (object near3 height)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:32
S35	1048	johns.xp.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:32
S36	1	(Hitachi.as. and (object near3 height)) and johns.xp.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:33
S37	14268	(different near6 (length\$1 or size\$1 or dimension\$1)) same (slit\$1 or segment\$1 or sector\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:39
S38	277	((different near6 (length\$1 or size\$1 or dimension\$1)) same (slit\$1 or segment\$1 or sector\$1)) and (mov\$3 near3 object)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:37
S39	7	(US-5329595-\$ or US-5771485-\$ or US-6766038-\$ or US-6005493-\$). did. or (JP-08221577-\$).did. or (JP-08221577-\$ or EP-913799-\$). did.	USPAT; JPO; DERWENT	OR	OFF	2004/09/06 15:46

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S40	, 0	((different near6 (length\$1 or size\$1 or dimension\$1)) same (slit\$1 or segment\$1 or sector\$1)) and ((US-5329595-\$ or US-5771485-\$ or US-6766038-\$ or US-6005493-\$).did. or (JP-08221577-\$).did. or (JP-08221577-\$ or EP-913799-\$). did.)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:37
S41	0	((US-5329595-\$ or US-5771485-\$ or US-6766038-\$ or US-6005493-\$). did. or (JP-08221577-\$).did. or (JP-08221577-\$ or EP-913799-\$). did.) and (different near6 (length\$1 or size\$1 or dimension\$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:39
S42	0	((US-5329595-\$ or US-5771485-\$ or US-6766038-\$ or US-6005493-\$). did. or (JP-08221577-\$).did. or (JP-08221577-\$ or EP-913799-\$). did.) and ((different or multiple or two) near6 (length\$1 or size\$1 or dimension\$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:39
S43	11	((different near6 (length\$1 or size\$1 or dimension\$1)) same (slit\$1 or segment\$1 or sector\$1) same (mov\$3 near3 object\$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:57
S44	0	((US-5329595-\$ or US-5771485-\$ or US-6766038-\$ or US-6005493-\$). did. or (JP-08221577-\$).did. or (JP-08221577-\$ or EP-913799-\$). did.) and cod\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:47
S45	0	((US-5329595-\$ or US-5771485-\$ or US-6766038-\$ or US-6005493-\$). did. or (JP-08221577-\$).did. or (JP-08221577-\$ or EP-913799-\$). did.) and cod\$7	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:47
S46	2113	(moving near4 object\$6) same cod\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:47
S47	21	((moving near4 object\$6) same cod\$3) and slits	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:47
S48	9	((different near4 (length\$1 or size\$1)) same (slit\$1 or segment\$1 or sector\$1) same (mov\$3 near3 object\$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:58

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S49	12102	(different near4 (length\$1 or size\$1)) same (slit\$1 or segment\$1 or sector\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:58
S50	231	((different near4 (length\$1 or size\$1)) same (slit\$1 or segment\$1 or sector\$1) and (mov\$3 near3 object\$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:59
S51	2	"5721692".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 19:12
S52	0	"5721692".pn. and cod\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 19:12
S53		"5721692".pn. and (cod\$3 or label\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 19:12
S54	4	"5721692".pn.",4160522".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 19:26
S55	2	"4459487".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 19:34
S56	5741	382/100,103,104, 107;73/488;348/154,155;356/27, 28,28.5.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR .	OFF	2005/05/30 14:11
S57	5796	382/100,103,104, 107;73/488;348/154,155;356/11, 27,28,28.5.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:11
S58	742	S57 and (((imag\$4 frame\$1) same (slit\$5 area\$4 region\$4 block\$4 rectangl\$6)) same (height\$ length\$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:17

S59	536	S58 and ((two three multipl\$4 plural\$4 several myriad different unequal) near4 (slit\$5 area\$4 region\$4 block\$4 rectangl\$6))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:37
S60	115	S59 and ((object\$1 subject\$1 person\$1 individual\$4 automobil\$ vehic\$6 car\$1 truck\$1 bus\$3) near3 (height\$ length\$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:39
S61	79	S60 and ((detect\$4 comput\$4 determin\$5 calculat\$4 obtain\$4 generat\$4) near5 (height\$1 length\$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:41
S62	4735	((two double\$4 three triple\$1 multipl\$4 plural\$4 several myriad different unequal) near4 (slit\$5 area\$4 region\$4 block\$4 rectangl\$6 segment\$1 line\$1 strip\$4)) same ((object\$1 subject\$1 person\$1 individual\$4 automobil\$ vehic\$6 car\$1 truck\$1 bus\$3) near3 (height\$ length\$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:40
S63	1591	S62 and ((detect\$4 comput\$4 determin\$5 calculat\$4 obtain\$4 generat\$4) near5 (height\$1 length\$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:41
S64	1092	S63 and (imag\$3 video\$ frame\$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 15:23



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IEE CNI	Proceeding			Femtosecond self- and cross-phase modulation in semiconductor laser amplifier Hong, M.Y.; Chang, Y.H.; Dienes, A.; Heritage, J.P.; Delfyett, P.J.; Dijaili, S.; Patterson Selected Topics in Quantum Electronics, IEEE Journal of Volume 2, Issue 3, Sept. 1996 Page(s):523 - 539
STD	IEEE Standard			AbstractPlus References Full Text: PDF(448 KB) IEEE JNL
				Improved SPECT quantitation using fully three-dimensional iterative spatially var response compensation Beekman, F.J.; Kamphuis, C.; Viergever, M.A.; Medical Imaging, IEEE Transactions on Volume 15, Issue 4, Aug. 1996 Page(s):491 - 499
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